Rcpt. ASS'Y USB R/A, Series B.

1. SCOPE

This specification covers performance, tests and quality requirements for Rcpt. ASS'Y USB R/A, Series B connector.

2. APPLICABLE DOCUMENT

The following documents form a part of this specification to the extent specified herein. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

Test Report: 501-57043.

3. REQUIREMENTS

3.1. DESIGN AND CONSTRUCTION

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

3.2. MATERIALS

- A. Contact: Copper Alloy, Gold plating on contact area, Tin-lead or Tin plated on soldertails, Nickel underplated all over
- B. Housing: Thermoplastic High Temperature, UL94V-0.
- C. Front Shell: Copper Alloy, Nickel plated over Cu underplated all over.
- D. Rear Shell: Steel, Nickel plated over Cu underplated all over.

3.3. RATINGS

- A. Temperature range: -55°C to +85°C
- B. Current rating: 1 Ampere.
- C. Voltage rating: 30 VAC RMS Max.

3.4. PERFORMANCE AND TEST DESCRIPTION

The product is designed to meet the electrical, mechanical and environmental performance requirements specified in Figure 1.

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			FZ00-0164-04





3.5. TEST REQUIREMENTS AND PROCEDURES SUMMARY

TEST ITEM	REQUIREMENTS	PROCEDURE							
Examination of product	Meets requirements of product	Visual inspection							
drawing and Tyco Specification. No physical damage.									
ELECTRICAL TEST									
Termination Resistance (Low Level)	Initial: 30 m Ω Max. Final: 40 m Ω Max.	Subject mated contacts assembled in housing to 20 mV Max. Open circuit at 100 mA Max. See figure 3. EIA 364-23							
Insulation Resistance	1000 MΩ Min.	Test between adjacent contacts of mated and unmated connector assemblies. EIA 364-21.							
Dielectric Withstanding Voltage	No creeping discharge nor flash over.	Test between adjacent contacts of mated and unmated connector assemblies.750 Vac for 1 minute. EIA 364-20							
Capacitance	2 pF Max.	Test between adjacent circuits of unmated connectors at 1 KHz. EIA 364-30							
	MECHANICAL TEST								
Connector Mating Force	Initial: 35 N Max.	Measure force necessary to mate connector assemblies at Max. Rate of 12.5 mm/min. EIA 364-13							
Connector Unmating Force	Initial: 10 N Min.	Measure force necessary to mate connector assemblies at Max. Rate of 12.5 mm/min. EIA 364-13							
Durability	See note (a).	Mate and unmate connector assemblies for 1500 cycles at Max. Rate of 200 cycles per hour. EIA 364-09							
Vibration	No electrical discontinuity of 1 microsecond or longer duration. See note (a).	Subject mated connectors to 5.35 G's rms. 15 minutes in each of three mutually perpendicular planes. See figure 4. EIA 364-28 condition V, Test letter A.							
Physical Shock Contact Retention	No electrical discontinuity of 1 microsecond or longer duration. See note (a).	Subject mated connectors to 30 G's half-sine shock pulses of 11 ms duration. Three shocks in each direction applied along three mutually perpendicular planes, 18 total shocks. See figure 4 for the test setup. EIA 364-27 condition H. Apply axial load to contact.							

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ENVIRONMENTAL TEST							
Thermal Shock	Ins. resistance: $500 \text{ M}\Omega$ Min. Dielectric Withstanding Voltage: 750 V ac 1min. See note (a).	Mated connector. −55°C / 30min., 85°C / 30min. 5 cycles. EIA 364-32 test condition I.					
Humidity Test	See note (a).	Mated connectors. 40°C with 90∼95% R.H. for 96 hours. EIA 364-31 method II test condition A.					
Temperature Life	See note (a).	Mated connectors. 85 ±5℃ 250 hours. EIA 364-17 test condition 3 method A.					
Solderability	Wet Solder Coverage: 95% Min.	Solder Temperature: 245±5°C Immersion Duration: 5±0.5sec. EIA 364-52					
Resistance to Soldering Heat	1). No mechanical defect on housing or other parts. 2). The critical to function properties or dimensions don't exceed the requirements of the product specification.	Component Terminal Fluxing: 1.The terminal leads to be tested shall be immersed in the flux described in paragraph 3. For 5 to 10 seconds. 2.Draining for to 20 seconds shall eliminate excess flux. Rate: 25±2.5mm/sec. Temperature: 265 ± 5°C Immersion duration: 10 ± 0.5 sec. AMP spec-109-202.					

Figure1.

Note: (a) Shall meet visual requirements, show no physical damage, and shall meet requirements of additional tests as specified in the test sequence listed in figure 2.

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3.6. PRODUCT QUALIFICATION AND REQUALIFICATION TEST SEQUENCE

	Test Group (a)					
Test or Examination	Α	В	С	D	Е	
	Test Sequence (b)					
Examination of Product	1,9	1,5	1,9	1,3	1,3	
Termination Resistance (Low Level)	3,7	2,4				
Insulation Resistance			3,7			
Dielectric Withstanding Voltage			4,8			
Connector Mating Force	2					
Connector Unmating Force	8					
Durability	4					
Capacitance			2			
Vibration	5					
Physical Shock	6					
Thermal Shock			5			
Humidity Test			6			
Temperature Life		3 (c)				
Solderability				2		
Resistance to Soldering Heat					2	

Figure 2

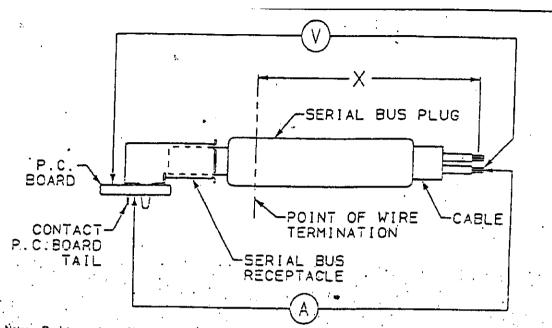
Notes: (a) See Para 4

- (b) Numbers indicate sequence in which tests are performed.
- (c) Precondition samples with 10 cycles durability.

4. SAMPLE SELECTION

Samples shall be prepared in accordance with applicable manufacturers' instructions and shall be selected at random from current production. Test groups 1,2, 3 and 4 shall consist of a minimum of eight connectors. A minimum of 30 contacts shall be selected and identified. Unless otherwise specified, these contacts shall be used for all measurements.

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Note: Resistance due to X inches of wire shall be removed from all readings.

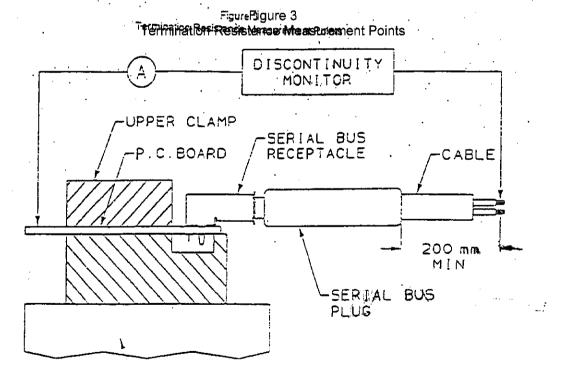


Figure 4
Vibration & Physical Shock Mounting Fixture.

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